

<b>Notice of References Cited</b>	Application/Control No. 10/640,349		Applicant(s)/Patent Under Reexamination SHIUAN ET AL.	
	Examiner Jeff Piziali		Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,046,709 A	04-2000	Shelton et al.	345/1.1
*	B	US-2002/0021274 A1	02-2002	Koyama et al.	345/98
*	C	US-6,593,930 B1	07-2003	Sheaffer et al.	345/531
*	D	US-7,634,668 B2	12-2009	White et al.	713/300
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.